## 10.7Cutoff Length Recommended

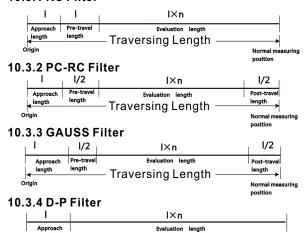
Ra (μm)	Rz (μm)	Cutoff length (mm)
>5~10	>20~40	- 2.5
> 2.5~5	>10~20	
>1.25~2.5	> 6.3~10	0.8
> 0.63~1.25	>3.2~6.3	
>0.32~0.63	>1.6~3.2	
>0.25~0.32	>1.25~1.6	0.25
> 0.20~0.25 > 0.16~0.20	> 1.0~1.25 > 0.8~1.0	
>0.125~0.16 >0.1~0.125 >0.08~0.1	> 0.63~0.8 > 0.5~0.63 > 0.4~0.5	
>0.063~0.08 >0.05~0.063 >0.04~0.05	>0.32~0.4 >0.25~0.32 >0.2~0.25	
>0.032~0.04 >0.025~0.032 >0.02~0.025	>0.16~0.2 >0.125~0.16 >0.1~0.125	

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# SURFACE ROUGHNESS TESTER

This Surface Roughness Tester is small in size, light in weight, easy to carry. Although complex and advanced, it is convenient to use and operate. Its ruggedness will allow many years of use if proper operating techniques are followed. Please read the following instructions carefully and always keep this manual within easy reach.

## 10.3.1 RC Filter



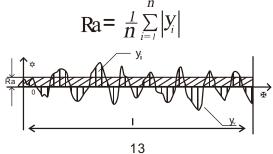
## 10.4 Definition of roughness parameter

# 10.4.1 Ra arithmetical mean deciation of profile

Traversing Length

Normal measuring

Arithmetic value of mean deciation of profile within sampling length.



# 2. Specifications

Display: LCD, with blue backlight Parameters: Ra, Rz, Rq, Rt

Display Range:
Ra=0.005~16um/0.020~629.9uinch
Rq=0.005~16um/0.020~629.9uinch
Rt=0.020~160.0um/0.780~6299uinch Rz=0.020~160.0um/0.780~6299uinch

Accuracy: Not more than ±10%

Fluctuation of display value: Not more than 6%

Sensor:

Test Principle: Inductance type Radius of Probe Pin: 5um Material of Probe Pin: Diamond

Measurement Force of Probe: 4mN(0.4gf)

Probe Angle: 90°

Vertical Radius of Guiding Head: 48mm Maximum driving stroke: 17.5mm/0.7inch Cutoff length (I): 0.25mm / 0.8mm / 2.5mm Driving speed:

sampling length = 0.25mm Vt=0.135mm/s Measuring range ≤1
sampling length = 0.8mm Vt=0.5mm/s
Measuring range ≤2.5
sampling length = 2.5mm Vt=1mm/s Measuring range =1 returning Vt=1mm/s

Profile digital filter

Filtered Profile: RC Filtered Profile: PC-RC Filtered Profile: Gauss Non-Filtered Profile: D-P

Resolution: 0.001µm if reading < 10µm

0.01µm if 10µm≤reading < 100µm

0.1µm if reading ≥100µ

Evaluation length: (1~5) cut-off optional Operating conditions: Temp. 0~50°C Humidity <80%

Power supply: 4x1.5AAA batteries Size: Main Unit: 149x67x29 mm

#### 1.Features

This instrument is compatible with four standards of ISO, DIN, ANSI and JIS and is widely used in production site to measure surface roughness of various machinery-processed parts, calculate corresponding parameters according to selected measuring conditions and clearly display all measurement parameters. When measuring the roughness of a surface, the sensor is placed on the surface and then uniformly slides along the surface by driving the mechanism inside the tester. The sensor gets the surface roughness by the sharp built-in probe. This roughness causes displacement of the probe which results in change of inductive amount of induction coils so as to generate analogue signal, which is in proportion to the surface roughness at output end of phasesensitive rectifier. The exclusive DSP processes and calculates and then outputs the measurement results on LCD.

- \* Multiple parameter measurement: Ra, Rz, Rq, Rt
- \* Four wave filtering methods : RC, PC-RC, GAUSS and D. P.
- \* Can communicate with PC computer for statistics, printing and analysing by the optional cable and the software for RS232C interface.
- \*Manual or automatic shut down. The tester can be switched off by pressing the Power key at any time. On the other hand, the tester will power itself off about 5 minutes after the last key operation.
- \*The tester can memorize 7 groups of measurement results and measuring conditions for later use or download to PC for analysing, printing.
- \*Metric /Imperial Conversion

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Sensor: 185x56x47mm Weight: 485g(Not including batteries)

**Standard Accessories:** 

Main unit
Screwdriver
Measuring base
Adjustable stand
Standard sensor
Standard sample plate
Sheath of sensor
Carrying case
Operation manual

Optional accessories:

Cable & software for RS232C Groove stylus Curvature Probe Extension rod

Measurement support Bluetooth interface

3.Front Panel Descriptions And Names Of Each Parts

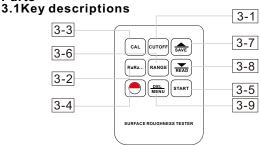


Fig. 3-1

3-1 Cutoff 3-4 Power 3-7 Up/Save 3-2 Parameter 3-5 Start 3-8 Down/Read 3-3 Calibration key 3-6 Range 3-9 Delete/Menu

## 10.4.2 Rz ten point height of irregularities

The average of the sum of five maximum profile peaks and the average of five maximum profile valleys withinthe sampling length.

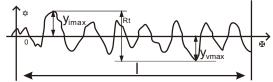
$$R_{Z} = \frac{\sum_{i=1}^{5} \frac{1}{2_{i}} + \sum_{i=1}^{5} y_{V}}{5}$$

**10.4.3 Rq root-mean-square deviation of profile** Root-mean-square of profile deviation within the sampling length, shown as the following function

Rq =  $(\frac{1}{n}\sum_{3=1}^{5}\frac{1}{2}^{2})^{\frac{1}{2}}$ 

# 10.4.4 Rt total peak-to-valley height

Rt is the sum of maximum height of the profile peak and maximum depth of the profile valley for the evaluation length.



#### 10.5Fault Information

Err1 no data stored for browsing.

Err2 the Ra value of the standard sample is too small to be uses for calibration.

Err3 the value is too small to continue to decrease.

#### 10.6Code Standard Name

ISO4287 International Standard
DIN4786 German Standard

JISB601 Japanese Industrial Standard

ANSIB46.1 American Standard

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# 8. Communicate With PC

8.1Install the optional RS232C software to the PC. 8.2Connect the tester to the COM port of the PC with the optional RS232 cable.

8.3Run the software on the desktop and select the COM port in the system settings.

8.4Click the button of data collection, then click the button of Begin/Continue.

8.5 To download the groups stored in the Memory, just press the key (\*\*EDD).

#### 9. General Maintenance

\*Avoid crashes, intensive vibration, heavy dust, humidity, grease stains and strong magnetic fields;

- \*The sensor is a precise part and should be protected carefully. It is recommended to put it back in the box after each operation;
- \* Protect the standard sample plate belonging to the instrument carefully to avoid calibration faults caused by scratches.

#### 10.References

#### 10.1 Filter

**A.**RC filter: traditional 2-stage filter with phase difference;

B.PC-RC filter: RC filter with phase-correction;

C.Gauss filter: DIN4777

**D.** D-P non-filtered profile: adopt central line of Least Square Algorithm

#### 10.2Central Line

This tester adopts minimum central line of least square algorithm.

# 10.3Traversing Length

I=sampling lenght

n=number of sampling lenght

Ixn=evaluation lenght

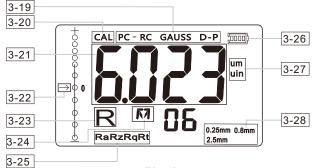


Fig. 3-5

3-19 Filter 3-24 Memory
3-20 Calibration 3-25 Parameters
3-21 Measurement 3-26 Battery
3-22 Position pointer 3-27 Unit
3-23 Browsing 3-28 Cutoff

3.3installation and unloading of sensor

To install, hold the main part of the sensor by hand, push it into connection sheath at the bottom of the instrument as shown in Figure 3-4 and then slightly push to the end of sheath. To unload, hold the main partof sensor or the root of protective sheath and slowlypull it out.

**A.**The probe of the sensor is the main part of this instrument and requires close attention.

**B.**During installation and unloading, the probe should not be touched in order to avoid damage which can affect measurement results.

C.Connection of the sensor should be reliable during installation.

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# 4.2 Measuring

After preparations is done, just press Start key to measureif measuring conditions are not to be changed. Firstly, you will see the '\_\_\_' on the display and the probe is moving forward and sampling. Then you will see the probe stop sliding and move backward. The measurement result shows on the display after the probe stop moving.

# 4.2.1 Save the measurement results to the tester for later use.

After measuring, you will see the original 'M' becomes the ' $\overline{M}$ '. In such a state, you can save this group of results including Ra, Rz, Rq, Rt and measurement conditions to the memory of the tester by depressing the key  $\widehat{M}$ . Then the symbol ' $\overline{M}$ ' changes to ' $\overline{M}$ ' automatically while the number of memorized groups increases 1.

# 4.2.2 How to browse the different parameters

#### 4.2.3 Delete the measurement results

 $\operatorname{In}'\overline{M}'$  state, you can delete this group of results by depressing the key. Then the symbol  $\overline{M}'$  changes to 'M' automatically. On the other hand, the new measurement results will replace the old ones if pressing the Start key in  $'\overline{M}'$  state.

#### 5. How to browse the memorized data

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## 4. Measuring Procedures

# 4.1 Preparations for measurement

A. Switch on to test if the battery voltage is normal.

**B.** The instrument automatically restores conditions of the last measurement before it is turned off since these conditions are automatically stored. Meanwhile, the second line of 2 digits on displayshows the groups stored in the memory. Before takingmeasurement, preparations have to be made and checked.

C. To check if the cutoff length selected is right. if not, Depress the to select. For the recommended cutoff length, please see the table in 10.7on page 15.

D. To check if the evaluation length selected is right. If not, depress the key [see], then for to select. To save and quit, just depress the key [see] again.

quit, just depress the key we again.

E. To check if the profile filter selected is right. If not, Depressing the And not releasing it till 'FIL T' on Display. It takes about 4 seconds from starting pressing the And then pressing key for key to cyclebetween RC, PC-RC, GAUSS, D-P or vice versa. To quit, just press any key other than key or key.

F. To check if the measurement unit selected is right. If not, depressing the key and not releasing it till 'UNIT' on the Display. It takes about 8 seconds from starting depressing key and then pressing for to switch between the metric system and the British system. To quit, just press any key otherthan key or key.

**G.** To check if the parameter selected is right. If not,depress the key 📾 to select. This step is very important.

H.To clear the surface of the part to be measured;

I. Refer to Figure 4-1 and Figure 4-2 to place the instrument correctly, stably and reliably on the surface to be measured.

**J.** Refer to Figure 4-2, the sliding trail of the sensor must be vertical to the direction of process line of themeasured surface.

K. Adjustable leg and sheath of sensor When the measured surface of the part is smaller than the measured surface of

the part is smaller than the bottom surface of the instrument, the sheath of sensor and adjustable leg can be used for auxiliary support to complete measurement.

(as shown in Figure 4-3)

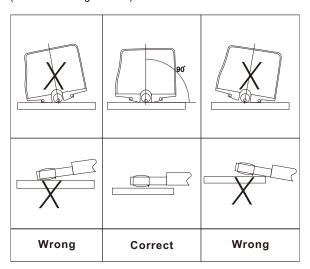


Fig.4-1



Fig.4-2

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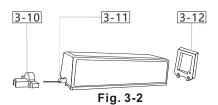
#### 6. How to calibrate the tester

6.1 When measuring on the standard wafer, if the measurement result is compared with the standard wafer and the deviation is greater than 10%, the factory Settings should be restored.

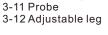
# 7. How to restore the factory settings

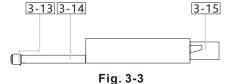
7.1Press the key and hold until "FAC" appears on the display. After 3 seconds, the number that keeps jumping appears. After 30 seconds, press any key except the power button to exit.

## 3.2Names of each parts



3-10 Sheath of probe

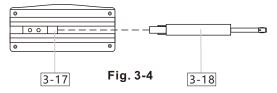




3-13 Stylus

3-14 Protection sleeve

3-15 Socket

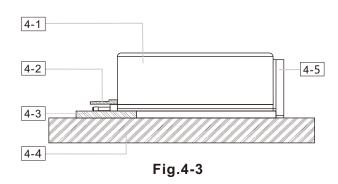


3-17 Connection sheath

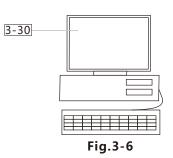
3-18 probe

4

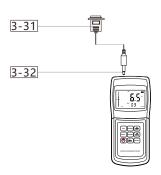
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- 4-1 Roughness tester
- 4-2 Sheath of probe
- 4-3 Item to be measured
- 4-4 Working table
- 4-5 Adjustable leg



Connection of Power Adapter and RS232C



3-30 Computer

3-31 RS-232 port to PC COM

3-32 RS-232 socket